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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Hiroshi YOSHIDA et al.

Serial Number: Not Yet Assigned

(§371 of international application No. PCT/JP03/07447)

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#### INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

December 17, 2004

Sir:

In compliance with 37 CFR 1.56, Applicants call to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449.

A copy of each of the references is enclosed herewith, except for the U.S. references.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. <u>50-2866</u>.

Respectfully submitted,

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Enclosures: PTO-1449; References (10) and international search report.

INFORMATION DISCLOSURE STATEMENT PTO-1449 Atty. Docket No. 043025

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Applicant(s): Hiroshi YOSHIDA et al.

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Group Art Unit:

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Examiner Initial		Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
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AC AE AF AC AH	JP2003-248909 JP2003-229614 JP11-135857 JP2000-106462	07/14/00 09/05/03 08/15/03 05/21/99 04/11/00 05/17/02 04/05/01	Japan Japan Japan Japan Japan Japan PCT	Abstract. Cited in the int'l. search report. Abstract. Cited in the int'l. search report. Abstract. Cited in the int'l. search report. Abstract. Discussed in the specification. Abstract. Discussed in the specification. Abstract. Abstract.

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Examiner		Date Considered